

Search Notes

Application/Control No.

10/083,718

Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination

ALSLIETY, MAZEN K.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	700MS, 792.5, 793, 795, 815	10/17/2005	CHEN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
343	700MS	10/17/2005	CHEN
343	815	10/17/2005	CHEN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Search items: Yagi dipole, substrate, driven element, parasitic)	10/17/2005	CHEN